

# Changzhou Wujin Dacheng Industry & Trade Co., Ltd.

# **TEST REPORT**

#### **SCOPE OF WORK:**

EMC directive (2014/30/EU) – EMC report

#### Model:

DM-130H, DL-DM03-E1

#### **REPORT NUMBER**

220602652SHA-001

#### **ISSUE DATE**

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Report no. 220602652SHA-001

Applicant : Changzhou Wujin Dacheng Industry & Trade Co., Ltd.

Niutang Town, Wujin, Jiangsu, 213163, P. R. China.

Manufacturer : Same as applicant

Factory : Same as applicant

#### **Summary**

The equipment complies with the requirements according to the following standard(s) or Specification:

**EN IEC 55014-1: 2021**: Electromagnetic compatibility - Requirements for household appliances, electric tools and similar apparatus Part 1: Emission

**EN IEC 55014-2: 2021**: Electromagnetic compatibility - Requirements for household appliances, electric tools and similar apparatus Part 2: Immunity – Product family standard

**EN IEC 61000-3-2: 2019+A1: 2021**: Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current ≤ 16A per phase)

**EN 61000-3-3:2013+A1:2019+A2:2021**: Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16A per phase and not subject to conditional connection

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# **Revision History**

Report No.	Version	Description	Issued Date
220602652SHA-001	Rev. 01	Initial issue of report	August 5, 2022



# **Measurement result summary**

TEST ITEM	TEST RESULT	NOTE
Mains terminal continuous disturbance voltage	Pass	
Mains terminal discontinuous disturbance voltage/click	NA	
Continuous disturbance power	Pass	
Radiated Emission	Pass	
Harmonics	Pass	
Voltage fluctuation-Flicker	Pass	
Electrostatic Discharge (ESD)	Pass	
Radio frequency electromagnetic fields	NA	
Fast transients	Pass	
Surges	Pass	
Injected Current	Pass	
Voltage dips	Pass	

#### Notes:

- 1. NA =Not Applicable
- 2. Determination of the test conclusion is based on IEC Guide 115 in consideration of measurement uncertainty.
- 3. Additions, Deviations and Exclusions from Standards: None.



#### 1. GENERAL INFORMATION

#### 1.1 Description of Equipment Under Test (EUT)

Product name : Mini Grinder

Type/Model: DM-130H, DL-DM03-E1

Description of EUT : The products covered in this report are hand-held motor-operated

electric mini grinders. Intended use: Polishing, grinding, sharpening, engraving, cutting, working with wire brush, drilling etc. DL-DM03-E1 is identical with DM-130H except for the model name. After evaluation, we

tested DM-130H and listed the worst data.

Rating : 220-230V<sup>~</sup>, 50Hz, n: 10000-35000min-1, Φ35mm for grinding disc(max),

Φ3,2mm for drilling bit(max), Class II,130W

Brand name : N/A

Highest clock frequency : <15MHz

Mains lead : (un)shielded, (non)detachable

Data cable : None.

EUT type : X Table-top

Floor standing

Sample received date : June 28, 2022

Sample Identification : 0220627-18-001

No.

Date of test : June 28, 2022 ~ July 8, 2022



#### 1.2 Description of Test Facility

Name : Intertek Testing Services Shanghai

Address: Building 86, No. 1198 Qinzhou Road(North), Shanghai 200233, P.R. China

Telephone : 86 21 61278200

Telefax : 86 21 54262353

The test facility is : CNAS Accreditation Lab recognized, certified, or accredited by these FCC Accredited Lab

organizations Designation Number: CN0175

IC Registration Lab CAB identifier.: CN0051 VCCI Registration Lab

Registration No.: R-14243, G-10845, C-14723, T-12252

A2LA Accreditation Lab Certificate Number: CN0175



#### 2. TEST SPECIFICATIONS

#### 2.1 Normative Standards

IEC 61000-4-2:2008: Electromagnetic Compatibility (EMC) — Part 4-2: testing and measurement techniques — electrostatic discharge immunity test

IEC 61000-4-3:2006+A1:2007+A1:2010: Electromagnetic Compatibility (EMC) — Part 4-3: testing and measurement techniques — radiated, radio frequency, electromagnetic field immunity test

IEC 61000-4-4:2012: Electromagnetic Compatibility (EMC) — Part 4-4: testing and measurement techniques — electric fast transient/burst immunity test

IEC 61000-4-5:2014+A1:2017: Electromagnetic Compatibility (EMC) – Part 4-5: testing and measurement techniques – section 5: surge immunity test

IEC 61000-4-6:2013: Electromagnetic Compatibility (EMC) — Part 4-6: testing and measurement techniques — section 6: immunity to conducted disturbance, induced by radio frequency field

IEC 61000-4-11:2020: Electromagnetic Compatibility (EMC) — Part 4-11: testing and measurement techniques —voltage dips, short interruption and voltage variations immunity test

IEC 61000-4-20:2010: Electromagnetic compatibility (EMC) – Part 4-20: Testing and measurement techniques - Emission and immunity testing in transverse electromagnetic (TEM) waveguides

IEC 61000-4-22:2010: Electromagnetic compatibility (EMC) – Part 4-22: Testing and measurement techniques – Radiated emissions and immunity measurements in fully anechoic rooms (FARs)



#### 2.2 Mode of operation during the test

Within this test report, EUT was tested under all available operation modes (Working On) and tested under its rating voltage and frequency. Other voltage and frequency is specified if used.

#### 2.3 Test Peripherals used

Item No	Description	Band and Model	S/No
1	-	-	-

#### 2.4 Record of climatic conditions

Test Item	Temperature (°C)	Relative Humidity (%)	Pressure (Kpa)
Mains terminal continuous disturbance voltage	21	51	-
Mains terminal discontinuous disturbance voltage/click	NA	NA	-
Continuous disturbance power	21	51	-
Radiated Emission	NA	NA	-
Harmonics	22	51	-
Voltage fluctuation-Flicker	22	51	-
Electrostatic Discharge (ESD)	22	48	101
Radio frequency electromagnetic fields	NA	NA	-
Fast transients	22	50	-
Surges	22	50	-
Injected Current	21	48	-
Voltage dips	22	50	-

Notes: NA =Not Applicable



#### 2.5 Instrument list

Conducted	Emission/Disturbance	Power			
Used	Equipment	Manufacturer	Type	Internal no.	Due date
$\boxtimes$	Test Receiver	R&S	ESR7	EC 6194	2022-12-09
$\boxtimes$	Attenuator	Weinschel	68-6-44	EC 3043-9	2023-02-08
$\boxtimes$	A.M.N.	R&S	ESH2-Z5	EC 3119	2022-11-09
$\boxtimes$	Absorbing clamp	R&S	MDS 21	EC 2108	2023-06-04
Harmonics	/Flicker				
Used	Equipment	Manufacturer	Type	Internal no.	Due date
	Three phase	EM TEST	DPA503N	EC 5383	2023-07-18
	Harmonic-flicker system	EM TEST	NETWAVE-30- 400	EC 5383-2	2023-07-18
ESD					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
$\boxtimes$	ESD generator	TESEQ	NSG 437	EC 4792-4	2023-03-24
EFT/Surge/	Voltage Dips				
Used	Equipment	Manufacturer	Type	Internal no.	Due date
$\boxtimes$	Conduct immunity system	EM TEST	Compact nx	EC6202	2022-12-08
$\boxtimes$	Automatic transformer	EM TEST	Variac nx1-260- 16	EC6425	2022-12-08
Conducted	Immunity				
Used	Equipment	Manufacturer	Type	Internal no.	Due date
$\boxtimes$	Signal generator	R&S	SML 01	EC 2338	2022-12-09
$\boxtimes$	Power amplifier	AR	75A250	EC 3043-1	2023-07-08
$\boxtimes$	Attenuator	EM TEST	ATT6/75	EC 3043-3	2023-02-08
$\boxtimes$	CDN	Frankonia	CDN M2M316	EC 5969	2023-02-10
Tet Site					
Used	Equipment	Manufacturer	Type	Internal no.	Due date
$\boxtimes$	Shielded room	Zhongyu	-	EC 2838	2023-01-11
$\boxtimes$	Shielded room	Zhongyu	-	EC 2839	2023-01-11
$\boxtimes$	Semi-anechoic chamber	Albatross project	-	EC 3048	2022-08-22
Additional	instrument				
Used	Equipment	Manufacturer	Type	Internal no.	Due date
$\boxtimes$	Thermo- Hygrograph	ZJ1-2A	S.M.I.F.	EC 3783	2023-03-25
$\boxtimes$	Thermo-	ZJ1-2A	S.M.I.F.	EC 5198	2023-03-08



	Hygrograph				
$\boxtimes$	Thermo- Hygrograph	ZJ1-2A	S.M.I.F.	EC 3442	2023-02-03
$\boxtimes$	Thermo- Hygrograph	ZJ1-2A	S.M.I.F.	EC 5844	2023-03-08
$\boxtimes$	Pressure meter	YM3	Shanghai Mengde	EC 3320	2023-07-21



#### 2.6 Measurement Uncertainty

Measurement	Frequency	Expanded Uncertainty (k=2) (±)
Conducted emission at mains norts	9kHz ~ 150kHz	3.52 dB
Conducted emission at mains ports	150kHz ~ 30MHz	3.19 dB
Continuous disturbance voltage at telecom ports	150kHz ~ 30MHz	3.64 dB
Continuous disturbance current at telecom ports	150kHz ~ 30MHz	2.62 dB
Mains terminal discontinuous disturbance voltage/click	-	3.76 dB
Continuous disturbance power	30MHz ~ 300MHz	4.35 dB
Radiated Emissions up to 1 GHz	30MHz ~ 1GHz	4.90 dB
Radiated Emissions above 1 GHz	1GHz ~ 6GHz	5.02 dB
Radiated Ellissions above 1 GHZ	6GHz ~ 18GHz	5.28 dB
Harmonic current emission	-	3.90%
Voltage fluctuations and flicker	-	10.34%
ESD	-	6.65%
Radiated susceptibility	-	2.38%
EFT test at main terminal	-	11.57%
EFT test at signal/telecom terminal	-	11.62%
Surge test at main terminal	-	11.57%
Injected current test at main terminal	-	1.88 dB
Injected current test at unshielded signal terminal	-	3.41 dB
Voltage dips and interruption	-	6.05%



#### **Emission Test**

# 3. Mains/Load/Control Terminal Continuous Disturbance Voltage

Test result: Pass

#### 3.1 Terminal Voltage Limits for the frequency range 9kHz to 30MHz

#### 3.1.1 General limits

	Mains ports		Auxiliary ports			
Frequency range (MHz)	Disturbance voltage		Disturbance voltage		Disturbance current	
(141112)	Limits dB(μV)		Limits dB(μV)		Limits dB(μA)	
	Quasi-pea	k Average	Quasi-peak	Average	Quasi-peak	Average
0.15 ~ 0.5	66 ~ 56 *	59 ~ 46 *	80	70	40 ~ 30 *	30 ~ 20 *
0.5 ~ 5.0	56	46	74	64	30	20
5.0 ~ 30	60	50	74	64	30	20

#### Notes:

- 1. \* means the limit decreasing linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.
- 2. If the quasi-peak measurements meet the average limit, the EUT shall be deemed to meet both limits and the measurements using the average detector need not be carried out.

#### 3.1.2 Limits for mains port of motor operated tools

	P ≤ 700 W		$700 \text{ W} < P \le 1000 \text{ W}$		P > 1 000 W	
Frequency range	Limits dB(μV)		Limits dB(μV)		Limits dB(μV)	
(MHz)	Quasi-pea	k Average	Quasi-peak	Average	Quasi-peak	<ul><li>Average</li></ul>
0.15 ~ 0.35	66 ~ 59*	59 ~ 49*	70 ~ 63*	63 ~ 53*	76 ~ 69*	69 ~ 59 *
0.35 ~ 5	59	49	63	53	69	59
5 ~ 30	64	54	68	58	74	64

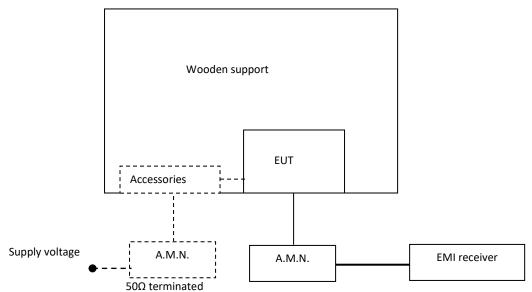
#### Notes:

- 1. \* means the limit decreasing linearly with the logarithm of the frequency in the range 0.15MHz to 0.35MHz.
- 2. If the quasi-peak measurements meet the average limit, the EUT shall be deemed to meet both limits and the measurements using the average detector need not be carried out.



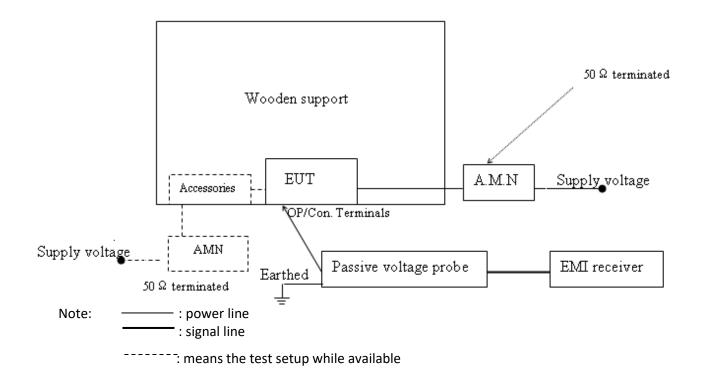
#### 3.2 Block Diagram of Test Setup

At mains terminal



For table top equipment, wooden support is 0.8m height table. For floor standing equipment, wooden support is 0.1m height rack.

At Associated ports





#### 3.3 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were according to clause 5.1 of EN 55014-1 if applicable.

Detailed test procedure and arrangement was according to clause 5.2 of EN 55014-1.

Measurement methods was according to clause 5.4 of EN 55014-1.

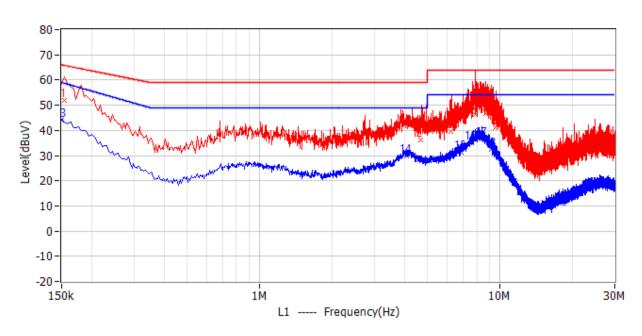
Operation conditions of EUT was according to clause 6 of EN 55014-1.

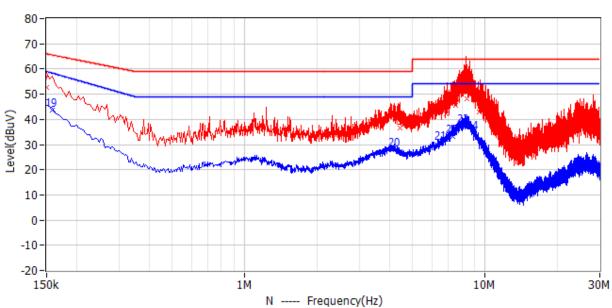
Frequency range  $150 \, \text{kHz} - 30 \, \text{MHz}$  was checked and EMI receiver measurement bandwidth was set to  $9 \, \text{kHz}$ .



#### 3.4 Test Protocol

#### For Mains ports: Pass





No.	Frequency	Limit dBuV	Level dBuV	Delta dB	Reading dBuV	Factor dB	Detector	Phase
1	154.500kHz	65.8	51.9	-13.9	45.7	6.2	QP	L1
2	4.686MHz	59.0	36.0	-23.0	29.7	6.3	QP	L1
3	6.252MHz	64.0	39.7	-24.3	33.4	6.3	QP	L1
4	7.859MHz	64.0	46.3	-17.7	40.0	6.3	QP	L1
5	8.709MHz	64.0	46.7	-17.3	40.4	6.3	QP	L1
6	9.564MHz	64.0	41.2	-22.8	34.9	6.3	QP	L1
7	150.000kHz	66.0	52.8	-13.2	46.6	6.2	QP	N



No.	Frequency	Limit dBuV	Level dBuV	Delta dB	Reading dBuV	Factor dB	Detector	Phase
8	4.430MHz	59.0	36.5	-22.5	30.2	6.3	QP	N
9	6.909MHz	64.0	42.3	-21.7	35.9	6.4	QP	N
10	7.566MHz	64.0	45.4	-18.6	39.0	6.4	QP	N
11	8.385MHz	64.0	48.3	-15.7	41.9	6.4	QP	N
12	9.456MHz	64.0	42.8	-21.2	36.4	6.4	QP	N
13	150.000kHz	59.0	44.0	-15.0	37.8	6.2	CAV	L1
14	4.083MHz	49.0	29.9	-19.1	23.6	6.3	CAV	L1
15	6.869MHz	54.0	31.3	-22.7	25.0	6.3	CAV	L1
16	7.620MHz	54.0	35.2	-18.8	28.9	6.3	CAV	L1
17	8.412MHz	54.0	36.6	-17.4	30.3	6.3	CAV	L1
18	9.209MHz	54.0	32.3	-21.7	26.0	6.3	CAV	L1
19	159.000kHz	58.3	43.8	-14.5	37.5	6.3	CAV	N
20	4.218MHz	49.0	28.0	-21.0	21.7	6.3	CAV	N
21	6.590MHz	54.0	30.6	-23.4	24.2	6.4	CAV	N
22	7.337MHz	54.0	33.2	-20.8	26.8	6.4	CAV	N
23	8.196MHz	54.0	37.2	-16.8	30.8	6.4	CAV	N
24	8.939MHz	54.0	34.7	-19.3	28.3	6.4	CAV	N

Remark: 1. Factor = LISN Factor + Cable Loss + Attenuator, the value was added to Original Receiver Reading by the software automatically.

- 2. Level = Reading + Factor
- 3. Delta = Level Limit
- 4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming LISN Factor = 10.00dB, Cable Loss = 2.00dB, Attenuator = 10.00dB

Original Receiver Reading = 10.00dBuV, Limit = 66.00dBuV.

Then Factor = 10.00 + 2.00 + 10.00 = 22.00dB;

Level = 10dBuV + 22.00dB = 32.00dBuV;

Delta = 32.00dBuV - 66.00dBuV = -34.00dB.

#### For Associated ports: NA

Remark: 1. Correct Factor = LISN Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.

- 2. Corrected Reading = Original Receiver Reading + Correct Factor
- 3. Margin = Limit Corrected Reading
- 4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming LISN Factor = 10.00dB, Cable Loss = 2.00dB,

Original Receiver Reading = 10.00dBuV, Limit = 66.00dBuV.

Then Correct Factor = 10.00 + 2.00 = 12.00dB;

Corrected Reading = 10dBuV + 12.00dB = 22.00dBuV;

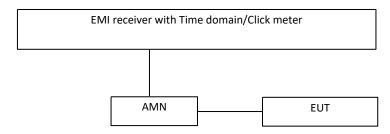
Margin = 66.00dBuV - 22.00dBuV = 44.00dB.



#### 4. Mains terminal discontinuous disturbance voltage/click

Test result: NA

#### 4.1 Block Diagram of Test Setup



#### 4.2 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were according to clause 5.1 of EN 55014-1 if applicable.

Detailed test procedure and arrangement was according to clause 5.2 of EN 55014-1.

Measurement methods was according to clause 5.4 of EN 55014-1.

Operation conditions of EUT was according to clause 6 of EN 55014-1.

0.15MHz, 0.5MHz, 1.4MHz and 30MHz were spot checked, and upper quartile methods used during measurement.

The final judgment of test result was according to figure 6 of EN 55014-1.



#### 4.3 Test Protocol

Frequency	0.45	0.5	4.4	20.0
(MHz)	0.15	0.5	1.4	30.0
Permitted limit				
for continuous interference	66.0	56.0	56.0	60.0
(dBμV)				
Counted click/switch operation				
number				
Hamber				
Observed time (min)				
Observed time (min)				
Click duration (ms)				
Click rate N				
Factor				
Permitted limits for clicks (dBμv)				
(				
Counted clicks exceeding the				
_				
limits				
Test result				
Any other descriptions:				



#### 5. Continuous disturbance power

Test result: Pass

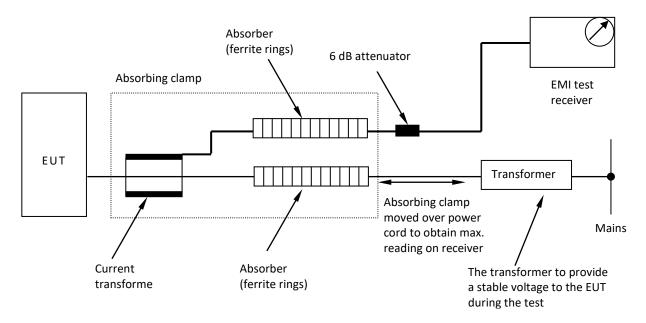
#### 5.1 Continuous disturbance power limit

	General		P ≤ 700 W		700 W < P ≤ 1 000 W		P > 1 000 W	
Frequency range	Limits dB(pW)		Limits dB(pW)		Limits dB(pW)		Limits dB(pW)	
(MHz)	Quasi-peak	Average	Quasi-peal	< Average	Quasi-peak	Average	Quasi-peak	<ul><li>Average</li></ul>
30 ~ 300	45 ~ 55*	35 ~ 45*	45 ~ 55*	35 ~ 45*	49 ~ 59*	39 ~ 49*	55 ~ 65*	45 ~ 55*

#### Notes:

- 1. \* means the limit decreasing linearly with the logarithm of the frequency in the range 30MHz to 300MHz.
- 2. If the quasi-peak measurements meet the average limit, the EUT shall be deemed to meet both limits and the measurements using the average detector need not be carried out.

#### 5.2 Block diagram of test set up



#### 5.3 Test Procedure

Measurement was performed in shielded room, and instruments used were according to clause 5.1 of EN 55014-1 if applicable.

Detailed test procedure and arrangement was according to clause 5.3 of EN 55014-1.

Measurement methods was according to clause 5.4 of EN 55014-1.

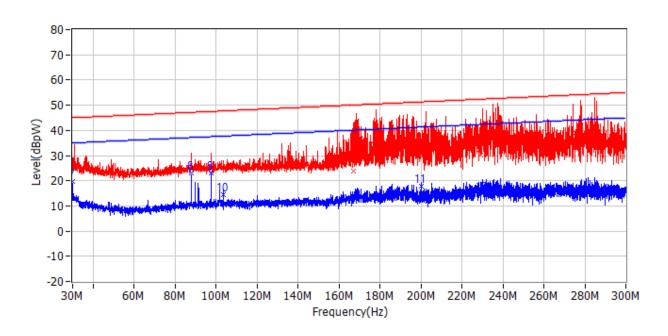
Operation conditions of EUT was according to clause 6 of EN 55014-1.

Frequency range 30MHz – 300MHz was checked and EMI receiver measurement bandwidth was set to 120kHz.



#### 5.4 Test Protocol

For Mains ports: Pass



No.	Frequency	Limit dBpW	Level dBpW	Delta dB	Reading dBuV	Factor dB	Detector
1	166.920MHz	50.1	23.8	-26.3	14.0	9.8	QP
2	176.760MHz	50.4	30.6	-19.8	20.9	9.7	QP
3	229.260MHz	52.4	30.3	-22.0	20.5	9.8	QP
4	236.040MHz	52.6	34.6	-18.1	24.8	9.8	QP
5	275.280MHz	54.1	35.0	-19.1	24.9	10.1	QP
6	285.360MHz	54.5	37.6	-16.8	27.3	10.3	QP
7	30.000MHz	35.0	19.6	-15.4	10.0	9.6	CAV
8	87.900MHz	37.1	23.2	-13.9	13.3	9.9	CAV
9	97.680MHz	37.5	22.9	-14.6	12.9	10.0	CAV
10	103.740MHz	37.7	14.4	-23.3	4.3	10.1	CAV
11	200.040MHz	41.3	17.7	-23.6	8.2	9.5	CAV
12	230.220MHz	42.4	14.9	-27.5	5.0	9.9	CAV

Remark: 1. Factor = Clamp Factor + Cable Loss + Attenuator, the value was added to Original Receiver Reading by the software automatically.

- 2. Level = Reading + Factor
- 3. Delta = Level Limit
- 4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Clamp Factor = 10.00dB, Cable Loss = 2.00dB,

Original Receiver Reading = 10.00dBpW, Limit = 66.00dBpW.

Then Factor = 10.00 + 2.00 = 12.00dB; Level = 10dBpW + 12.00dB = 22.00dBpW;

Delta = 22.00dBpW - 66.00dBpW = -44.00dB.



#### For Associated ports: NA

Remark: 1. Correct Factor = Clamp Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.

- 2. Corrected Reading = Original Receiver Reading + Correct Factor
- 3. Margin = Limit Corrected Reading
- 4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Clamp Factor = 10.00dB, Cable Loss = 2.00dB,

Original Receiver Reading = 10.00dBpW, Limit = 66.00dBpW.

Then Correct Factor = 10.00 + 2.00 = 12.00dB;

Corrected Reading = 10dBpW + 12.00dB = 22.00dBpW;

Margin = 66.00dBpW - 22.00dBpW = 44.00dB.



#### 6. Radiated emission

PAS	SS
	۲А

As for in the disturbance power test all emission readings from the EUT are lower than the applicable limits (Table 7) reduced by the margin (Table 8) and the maximum clock frequency is less than 30MHz, the EUT is deemed to comply with the Radiated Emission requirement without test.

#### 6.1 Limit

Radiated emission limit from frequency range 30MHz – 1000MHz

Frequency (MHz)	Permitted limit in dBµV/m (Quasi-peak) of Measurement Distance 3m	Permitted limit in dBµV/m (Quasi-peak) of Measurement Distance 10m
30 ~ 230	40	30
230 ~ 1000	47	37

#### Notes:

- 1. For the measurement distance other than 3m and 10m, the limit is varied according to 20dB/10 decades.
  - 2. The gray rows are selected items.

Radiated emission limit from frequency range 1GHz – 6GHz

Frequency (MHz)	Permitted limit in dBμV/m (Average) of Measurement Distance	Permitted limit in dBµV/m (Peak) of Measurement Distance
	3m	3m
1000 ~ 3000	50	70
3000 ~ 6000	54	74

#### Notes

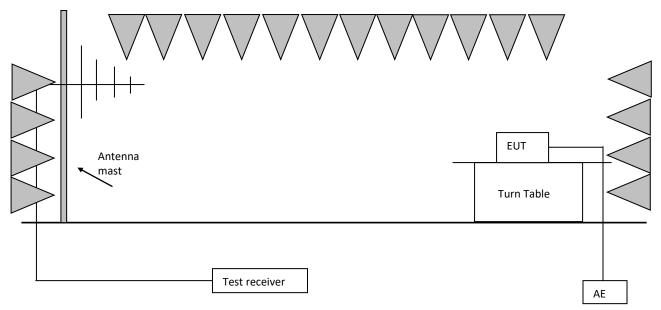
- 1. For the measurement distance other than 3m and 10m, the limit is varied according to 20dB/10 decades.
  - 2. The gray rows are selected items.

#### Required highest frequency for radiated electric field strength measurements

Highest clock frequency (F <sub>x</sub> )	Highest measurement frequency
F <sub>x</sub> ≤ 108 MHz	1 GHz
108 MHz < F <sub>x</sub> ≤ 500 MHz	2 GHz
500 MHz < F <sub>x</sub> ≤ 1 GHz	5 GHz
F <sub>x</sub> > 1 GHz	$5 \times F_x$ up to a maximum of 6 GHz



#### 6.2 Block diagram and test set up



The measurement was applied in a semi-anechoic chamber.

Operation conditions of EUT was according to clause 6 of EN 55014-1.

Measurement was performed according to clause 10 of CISPR 32.

Setting of EUT is according to clause 5.3.4.3 of EN 55014-1.

The bandwidth setting on test receiver was 120kHz.

The frequency range from 30MHz to 6GHz was checked.



#### 6.3 Test Protocol

Remark: 1. Factor = Antenna Factor + Cable Loss (+ Amplifier, for higher than 1GHz)

- 2. Level = Original Receiver Reading + Factor
- 3. Delta = Level Limit
- 4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Antenna Factor = 30.20dB/m, Cable Loss = 2.00dB,

Gain of Preamplifier = 32.00dB, Original Receiver Reading = 10.00dBuV, limit = 40.00dBuV/m.

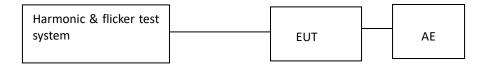
Then Factor = 30.20 + 2.00 - 32.00 = 0.20dB/m; Level = 10.00dBuV + 0.20dB/m = 10.20dBuV/m; Delta = 10.20dBuV/m - 40.00dBuV/m = -29.80dB.



#### 7. Harmonics

Test result: Pass

#### 7.1 Block Diagram of Test Setup



#### 7.2 Test Setup and Test Procedure

Harmonics of the fundamental current were measured up to 40 order harmonics using a digital power meter with an analogue output and frequency analyser which was integrated in the harmonic & flicker test system. The measurements were carried out under steady conditions. Measuring instrumentation according to IEC 61000-4-7:2002+A1:2008

<b>-</b> -	<b>T</b>	D I	1
7.3	Test	Prot	ncoi

This product is not defined as lighting equipment, and has rated power less than 75W, therefore, no limit apply according to EN 61000-3-2
The EUT is kitchen machines as listed in the scope of IEC 60335-2-14, therefore, is deemed to conform to the harmonic current limits of this standard without further testing.
Classification: Class A Class B Class D

#### **Current Test Result**

	Average and Maximum harmonic current results								
	Average (100% / 150% *)			Maximum (150%)				Harmonic	
Hn	Ieff [A]	of Limit [%]	Limit [A]	Result	Ieff [A]	of Limit [%]	Limit [A]	Result	Result
1	0.281				0.395				
2	0.001	0.052	1.620	n/a	0.002	0.068	2.430	n/a	n/a
3	0.034	0.994	3.450	PASS	0.067	1.289	5.175	PASS	PASS
4	0.001	0.142	0.645	n/a	0.002	0.174	0.968	n/a	n/a
5	0.007	0.393	1.710	PASS	0.011	0.435	2.565	PASS	PASS
6	0.001	0.226	0.450	n/a	0.001	0.213	0.675	n/a	n/a
7	0.001	0.084	1.155	n/a	0.002	0.123	1.733	n/a	n/a
8	0.001	0.234	0.345	n/a	0.001	0.220	0.518	n/a	n/a
9	0.001	0.136	0.600	n/a	0.001	0.130	0.900	n/a	n/a
10	0.001	0.321	0.276	n/a	0.002	0.454	0.414	n/a	n/a
11	0.001	0.218	0.495	n/a	0.002	0.232	0.743	n/a	n/a
12	0.001	0.378	0.230	n/a	0.002	0.503	0.345	n/a	n/a



13	0.001	0.332	0.315	n/a	0.002	0.327	0.473	n/a	n/a
								,	
14	0.001	0.396	0.197	n/a	0.001	0.418	0.296	n/a	n/a
15	0.001	0.348	0.225	n/a	0.001	0.351	0.338	n/a	n/a
16	0.001	0.444	0.173	n/a	0.001	0.527	0.259	n/a	n/a
17	0.001	0.391	0.199	n/a	0.002	0.642	0.298	n/a	n/a
18	0.001	0.623	0.153	n/a	0.003	1.156	0.230	n/a	n/a
19	0.001	0.535	0.178	n/a	0.003	1.194	0.266	n/a	n/a
20	0.001	0.750	0.138	n/a	0.003	1.573	0.207	n/a	n/a
21	0.001	0.422	0.241	n/a	0.003	1.322	0.241	n/a	n/a
22	0.001	0.815	0.125	n/a	0.003	1.516	0.188	n/a	n/a
23	0.002	0.784	0.220	n/a	0.003	1.336	0.220	n/a	n/a
24	0.001	0.871	0.115	n/a	0.002	1.375	0.173	n/a	n/a
25	0.002	0.752	0.203	n/a	0.002	1.140	0.203	n/a	n/a
26	0.001	0.809	0.106	n/a	0.002	1.301	0.159	n/a	n/a
27	0.001	0.439	0.188	n/a	0.001	0.499	0.188	n/a	n/a
28	0.001	0.751	0.099	n/a	0.001	0.607	0.148	n/a	n/a
29	0.001	0.452	0.175	n/a	0.001	0.515	0.175	n/a	n/a
30	0.001	0.801	0.092	n/a	0.001	0.656	0.138	n/a	n/a
31	0.001	0.561	0.163	n/a	0.001	0.651	0.163	n/a	n/a
32	0.001	0.937	0.086	n/a	0.001	0.797	0.129	n/a	n/a
33	0.001	0.571	0.153	n/a	0.001	0.696	0.153	n/a	n/a
34	0.001	0.996	0.081	n/a	0.001	0.870	0.122	n/a	n/a
35	0.001	0.587	0.145	n/a	0.001	0.740	0.145	n/a	n/a
36	0.001	1.028	0.077	n/a	0.001	0.998	0.115	n/a	n/a
37	0.001	0.614	0.137	n/a	0.001	0.774	0.137	n/a	n/a
38	0.001	1.066	0.073	n/a	0.001	1.165	0.109	n/a	n/a
39	0.001	0.607	0.130	n/a	0.001	1.005	0.130	n/a	n/a
40	0.001	1.080	0.069	n/a	0.001	1.331	0.104	n/a	n/a

Note: Harmonic currents less than 0.6 % of the input current measured under the test conditions, or less than 5 mA, whichever is greater, are disregarded.

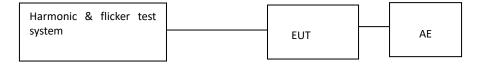
<sup>\*</sup> Application of limits for average is 100% except for odd harmonics from 21 to 39, where 150% applies.



#### 8. Voltage Fluctuations-Flicker

Test result: Pass

#### 8.1 Block Diagram of Test Setup



#### 8.2 Test Setup and Test Procedure

#### 8.2.1 Definition

Flicker: impression of unsteadiness of visual sensation induced by a light stimulus whose luminance

or spectral distribution fluctuates with time.

Pst: Short-term flicker severity.

Plt: long-term flicker severity.

dc: maximum steady state voltage change during an observation period.

dmax: maximum absolute voltage change during an observation period.

d(t): time function of the relative r.m.s. voltage change evaluated as a single value for each

successive half period between zero-crossings of the source voltage, except during time

interval in which the voltage is a steady-state condition for at least 1s.

#### 8.2.2 Test condition

The EUT was set to produce the most unfavorable sequence of voltage changes.



#### 8.3 Test Protocol

The tested object operated under the operating condition specified in EN 61000-3-3 The following limits apply

- the value of Pst shall not be greater than 1,0.
- the value of Plt shall not be greater than 0,65.
- Tmax, the accumulated time value of d(t) with a deviation exceeding 3,3 % during a single voltage change at the EUT terminals, shall not exceed 500 ms.
- the maximum relative steady-state voltage change, dc, shall not exceed 3,3 %.
- the maximum relative voltage change dmax, shall not exceed:

	4% without additional conditions.
	6 % for equipment which is:
	<ul> <li>switched manually, or</li> <li>switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.</li> </ul>
$\boxtimes$	7 % for equipment which is:
	<ul> <li>attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen</li> </ul>
	equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or
	– switched on automatically, or is intended to be switched on manually, no more
	than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.
	for manual switch, dmax is measured in accordance with Annex B of standard,
	average dmax is calculated from 24 times measurement.
	The rate power of the EUT is no greater than 75W, which is unlikely to produce significant voltage fluctuations or flicker by technical analysis and evaluation. So it is deemed to fulfil the requirements without testing.

Flicker Measurements				
	Max D <sub>c</sub>	Max D <sub>max</sub>	Max T <sub>max</sub>	
Line 1:	0.108	0.606	0	
Limits:	3.3	7	0.5	
Results:	PASS	PASS	PASS	



# **Immunity Test**

#### Performance criteria

The performance criteria are based on the general criteria of the standard and derived from the product specification

**Criterion A:** The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

Criterion B: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however no change of actual operating state or stored data is allowed to persist after the test. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.

**Criterion C:** Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.



# **Categories of apparatus**

	equipment containing no electronic control circuitry. (fulfill the relevant immunity requirements without testing)
⊠ Category II:	mains operated equipment containing electronic control circuitry with no clock frequency higher than 15 MHz. (Shall fulfill the tests: ESD, EFT, Inject current (150 kHz to 230 MHz), Surge, Voltage dips)
Category III	battery operated equipment not included in Category I. (Shall fulfill the tests: ESD, EFT, Inject current (150 kHz to 80 MHz), Radio frequency electromagnetic fields (80 MHz to (F) MHz), Surge)  Note: For Category III toys, the radio frequency electromagnetic fields test shall be applicable only for ride on toys.
Category IV	: mains operated equipment containing electronic control circuitry with a highest clock frequency greater than 15 MHz but lower than or equal to 200 MHz. (Shall fulfill the tests: ESD, EFT, Inject current (150 kHz to 80 MHz), Radio frequency electromagnetic fields (80 MHz to 1000 MHz), Surge, Voltage dips)
Category V:	mains operated equipment containing electronic control circuitry with a highest clock frequency greater than 200 MHz. (Shall fulfill the tests: ESD, EFT, Inject current (150 kHz to 80 MHz), Radio frequency electromagnetic fields (80 MHz to 6 GHz), Surge, Voltage dips)



## 9. Electrostatic Discharge (ESD)

Test result: PASS

#### 9.1 Severity Level and Performance Criterion

#### 9.1.1 Test level

1a – Contac	ct discharge	1b – Air discharge		
Level	Test voltage kV	Level	Test voltage kV	
1	2	1	2	
2	4	2	4	
3	6	3	8	
4	8	4	15	
X	Special	Х	Special	

#### Notes:

#### 9.1.2 Performance Criterion

Performance criterion: B/C\*

<sup>1.&</sup>quot;X" is an open level. The level has to be specified in the dedicated equipment specification. If higher voltages than those shown are specified, special test equipment may be needed.

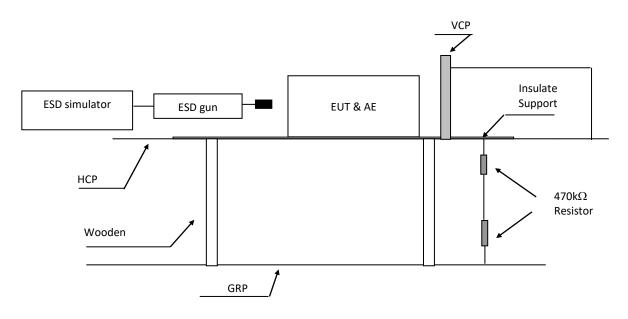
<sup>2.</sup> The gray rows were the selected test level.

<sup>\*:</sup> Performance criterion C may be applied to toys not using score or data entered by the user (e.g. musical soft toys and sounding toys).



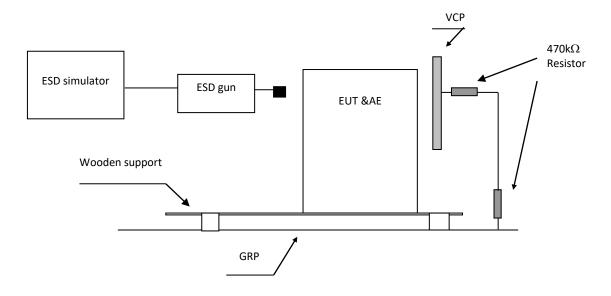
#### 9.2 Block Diagram of Test Setup

For table-top equipment



Note: HCP means <u>Horizontal Coupling Plane</u>
VCP means <u>Vertical Coupling Plane</u>
GRP means <u>Ground Reference Plane</u>
Wooden support is a 0.8m height table

For floor standing equipment



Note: VCP means <u>Vertical Coupling Plane</u> GRP means <u>Ground Reference Plane</u> Wooden support is a 0.1m height rack



#### 9.3 Test Setup and Test Procedure

Measurement was performed in shielded room.

Measurement and setting of EUT was applied according to IEC 61000-4-2 Clasuse 7.

The test method and equipment was specified by IEC 61000-4-2 with the modifications by EN 55014-2 clause 5.1.

#### 9.4 Test Protocol

Direct discharges were applied at the following selected points:

Test point #	Test level [kV]	Air/ Contact	Polarity (+/-)	Pass/Fail/NA	Comment
Α	4	Contact	+/-	Pass	All touchable screws of enclosure
В	4	Contact	+/-	Pass	Accessible metal parts of the EUT
С	8	Air	+/-	Pass	Air gap of the switch, button
D	8	Air	+/-	Pass	The air in-taking opening
E	8	Air	+/-	Pass	Slots around the EUT

Indirect contact discharges were applied to the VCP and the HCP at the following selected points:

Point	Description	Point	Pass/Fail/NA
VCP f	0,1m from the front of the EUT	Edge of centre, corner on VCP	Pass
VCP b	0,1m from the back of the EUT	Edge of centre, corner on VCP	Pass
VCP r	0,1m from the right of the EUT	Edge of centre, corner on VCP	Pass
VCP I	0,1m from the left of the EUT	Edge of centre, corner on VCP	Pass

# For table top equipment

Point	Description	Point	Pass/Fail/NA
HCP f	0,1m from the front of the EUT	Edge of centre, corner on HCP	Pass
HCP b	0,1m from the back of the EUT	Edge of centre, corner on HCP	Pass
HCP r	0,1m from the right side of the EUT	Edge of centre, corner on HCP	Pass
HCP I	0,1m from the left side of the EUT	Edge of centre, corner on HCP	Pass

**Observation:** All the functions were operated as normal during and after test. **Conclusion:** The EUT met the requirements of Performance Criterion B.



## 10. Radio frequency electromagnetic fields

Test result: NA

#### 10.1 Severity Level and Performance Criterion

#### 10.1.1 Test level

Level	Test field strength V/m
1	1
2	3
3	10
X	Special

#### Notes:

1. X is an open test level. This level may be given in the product specification.

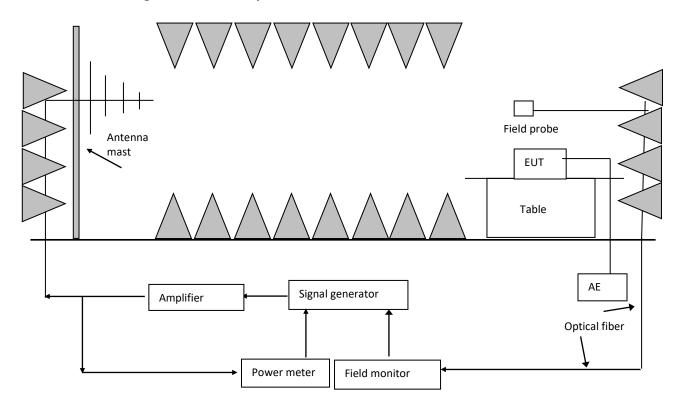
2. The gray row is the selected test level.

#### 10.1.2 Performance Criterion

Performance criterion: A



## 10.2 Block diagram of test setup



## 10.3 Test Setup and Test Procedure

Measurement was performed in full-anechoic chamber.

Measurement and setting of EUT was applied according to IEC 61000-4-3 clause 7.

The test method and equipment was specified by IEC 61000-4-3 with additions and modifications by EN 55014-2 clause 5.5.

## 10.4 Test Protocol

Test no.:	Frequency (MHz)	Polarization	Test level V/m	Modulation	Exposed location	Pass/Fail/NA	Comment
1	80-1000	H & V	3	1kHz, 80%, SW, AM, 1% step size	All sides	NA	-
1	1000-6000	H & V	3	1kHz, 80%, SW, AM, 1% step size	All sides	NA	-

**Observation:** 

**Conclusion:** 



## 11. Fast transients

Test result: Pass

## 11.1 Severity Level and Performance Criterion

## 11.1.1 Test level

Open circuit output test voltage (±10%) and repetition rate of the impulses (±20%)							
	Input and output	t AC power ports	Input and output DC power ports				
Level			Signal ports, control ports and wired				
			netwoi	network ports			
	Voltage peak	Repetition rate	Voltage peak	Repetition rate			
	kV	kHz	kV	kHz			
1	0.5	5	0.25	5			
2	1	5	0.5	5			
3	2	5	1	5			
4	4	5	2	5			
Х	Special	Special	Special	Special			

### Notes:

## 11.1.2 Performance Criterion

Performance criterion B

<sup>1. &</sup>quot;X" is an open level. The level has to be specified in the dedicated equipment specification.

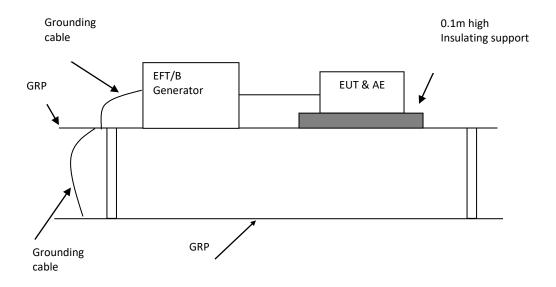
<sup>2.</sup> The gray rows were the selected test level.



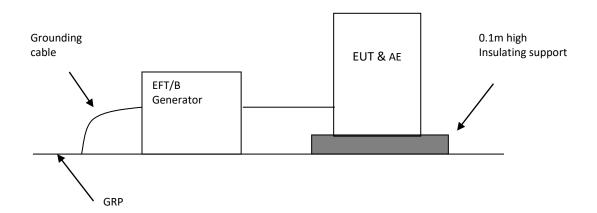
# 11.2 Block Diagram of Test Setup

## 11.2.1 Block Diagram for input a.c./d.c. power line

For table-top equipment



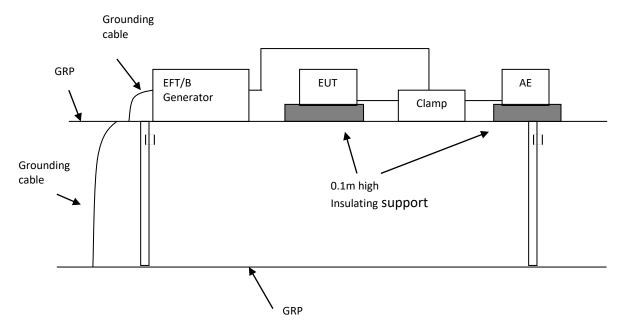
For floor standing equipment





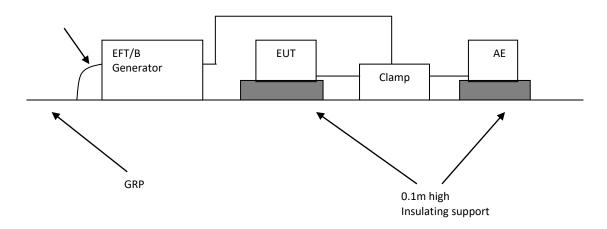
## 11.2.2 Block Diagram for output a.c./d.c. power line or signal/control lines

For table-top equipment



For floor standing equipment

Grounding cable



## 11.3 Test Setup and Test Procedure

Measurement was performed in shielded room.

Measurement and setting of EUT was applied according to IEC 61000-4-4 clause 7.

The test method and equipment was specified by IEC 61000-4-4 with additions and modifications by EN 55014-2 clause 5.2.



## 11.4 Test Protocol

Test No.	Level [kV]	Polarity +/-	Repetition rate kHz	Line for test	Pass/Fail/NA
1	1	+/-	5	Input and output AC power ports	Pass
2	0.5	+/-	5	Input and output DC power ports	NA
3	0.5	+/-	5	Signal ports, control ports and wired network ports	NA

**Observation:** All the functions were operated as normal during and after test. **Conclusion:** The EUT met the requirements of Performance Criterion B.



# 12. Surges

Test result: Pass

# 12.1 Severity Level and Performance Criterion

## 12.1.1 Test level

Level	Open-circuit test voltage ±10% kV
1	0.5
2	1.0
3	2.0
4	4.0
X*	Special

## Notes:

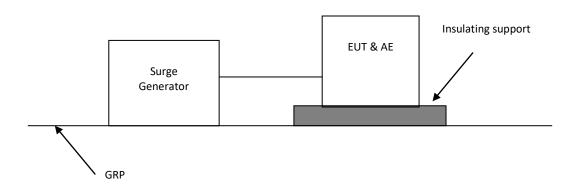
- 1."X" is an open class. This level can be specified in the product Specification
- 2. The gray rows are the selected level.

# 12.1.2 Performance Criterion

Performance criterion B



## 12.2 Block Diagram of Test Setup



## 12.3 Test Setup and Test Procedure

Measurement was performed in shielded room.

Measurement and setting of EUT was applied according to IEC 61000-4-5 clause 7. The test method and equipment was specified by IEC 61000-4-5 with modifications by EN 55014-2 clause 5.6.

### 12.4 Test Protocol

Test	Level	Polarity	Angle	Line for test	Pass/Fail/NA
No.	[kV]	+/-			
1	1	+	90°	Input AC power ports	Pass
		-	270°	(line to line)	
2	2	+	90°	Input AC power ports	NA
		-	270°	(line to earth)	
3	1	+	90°	Wired network ports	NA
		-	270°	(line-to-earth	
				(unshielded))	
4	0.5	+	90°	Wired network ports	NA
		-	270°	(shield-to-earth (shielded)	

**Observation:** All the functions were operated as normal during and after test. **Conclusion:** The EUT met the requirements of Performance Criterion B.



# 13. Injected Current

Test result: Pass

## 13.1 Severity Level and Performance Criterion

## 13.1.1 Test level

Frequency range 150kHz – 80MHz						
Level	Level Voltage level (e.m.f.)					
$U_0\left[dB(uV)\right] \qquad \qquad U_0\left(V\right)$						
1	120	1				
2	130	3				
3	140	10				
X Special Special						
Notes:						

- 1. "X" is an open level.
- 2. The gray row is the selected test level.

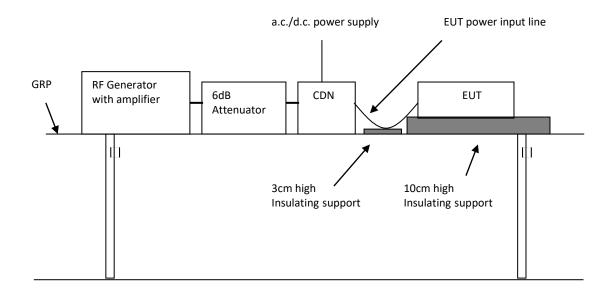
### 13.1.2 Performance Criterion

Performance criterion: A

## 13.2 Block Diagram of Test Setup

# 13.2.1 Block Diagram for a.c./d.c input power line

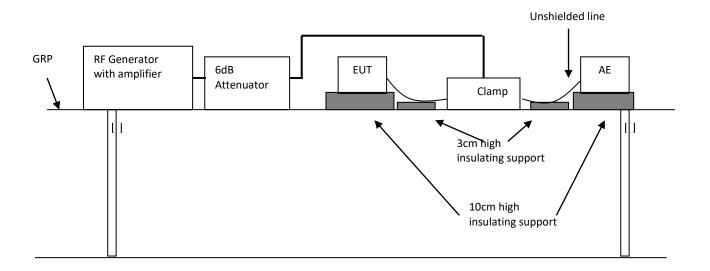
Block Diagram for a.c./d.c input power line



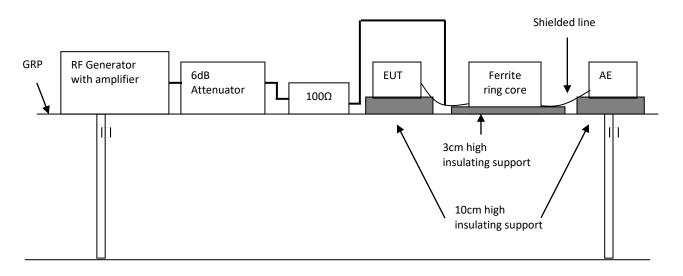


## 13.2.2 Block Diagram for output a.c./d.c. power line or signal/control lines

Unshielded line



Shielded line



## 13.3 Test Setup and Test Procedure

Measurement was performed in shielded room.

Measurement and setting of EUT was applied according to IEC 61000-4-6 clause 7.

The test method and equipment was specified by IEC 61000-4-6 with additions and modifications by EN 55014-2 clause 5.3, 5.4.



## 13.4 Test Protocol

⊠ EUT is not required for Radio frequency electromagnetic fields

Test	Frequency	Level	Modulation	Injected point	Pass/Fail/NA
No.	(MHz)	V (r.m.s.)			
1	0.15~230	3	1kHz, 80%, SW,	Input and output	Pass
			AM,	AC power ports	
			1% step size		
2	0.15~230	1	1kHz, 80%, SW,	Input and output	NA
			AM,	DC power ports	
			1% step size		
3	0.15~230	1	1kHz, 80%, SW,	Signal ports,	NA
			AM,	control ports and	
			1% step size	wired network	
				ports	

For EUT test Radio frequency electromagnetic fields

Test	Frequency	Level	Modulation	Injected point	Pass/Fail/NA
No.	(MHz)	V (r.m.s.)			
1	0.15~80	3	1kHz, 80%, SW,	Input and output	NA
			AM,	AC power ports	
			1% step size		
2	0.15~80	1	1kHz, 80%, SW,	Input and output	NA
			AM,	DC power ports	
			1% step size		
3	0.15~80	1	1kHz, 80%, SW,	Signal ports,	NA
			AM,	control ports and	
			1% step size	wired network	
				ports	

**Observation:** All the functions were operated as normal during and after test. **Conclusion:** The EUT met the requirements of Performance Criterion A.



## 14. Voltage Dips

Test result: Pass

## 14.1 Severity Level and Performance Criterion

#### 14.1.1 Test level

Test level	Voltage dip % U <sub>T</sub>	Duration (in period)	
% U <sub>T</sub>		50Hz	60Hz
0	100	0.5 cycle	0.5 cycle
40	60	10 cycles	12 cycles
70	30	25 cycles	30 cycles

### Notes:

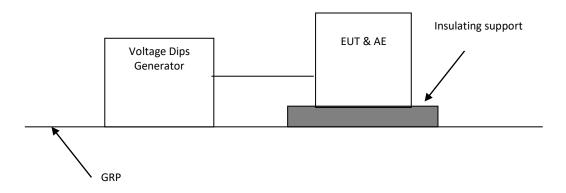
- 1."\*" for 0.5 period, the test shall be made in positive and negative polarity, i.e. starting at  $0^{\circ}$  and  $180^{\circ}$ , respectively.
- 2. "\*\*" means "x" is an open duration. This duration can be given in the product specification. Utilities in Europe have measured dips and short interruptions of duration between ½ a period and 3000 periods, but duration less than 50 periods are most common.
- 3. If the EUT is tested for voltage dips of 100%, it is generally unnecessary to test for other levels for the same durations. However, for some cases (safeguard systems or electro-mechanical devices) it is not true. The product specification or product committee shall give an indication of the applicability of this note.
  - 4. The gray rows are selected test level.

### 14.1.2 Performance Criterion

Performance criterion: C



## 14.2 Block diagram of test setup



## 14.3 Test Setup and Test Procedure

Measurement was performed in shielded room.

Measurement and setting of EUT was applied according to IEC 61000-4-11 clause 7.

The test method and equipment was specified by IEC 61000-4-11 with additions and modifications by EN 55014-2 clause 5.7.

#### 14.4 Test Protocol

Test no.	% U <sub>T</sub>	Voltage dips % UT	Duration (in periods)	Pass/Fail/NA
1	70	30%	25 cycles at 50Hz	Pass
			30 cycles at 60Hz	Pass
2	40	60%	10 cycles at 50Hz	Pass
			12 cycles at 60Hz	Pass
3	0	100%	0.5 cycle at 50Hz	Pass
			0.5 cycle at 60Hz	Pass

**Observation:** All the functions were operated as normal during and after test. **Conclusion:** The EUT met the requirements of Performance Criterion C.



# **Appendix I: Photograph of equipment under test**



Photo 1 (overview)



Photo 2 (overview)





Photo 3 (overview)



Photo 4 (overview)





Photo 5 (Brush cap)



Photo 6 (Switch)



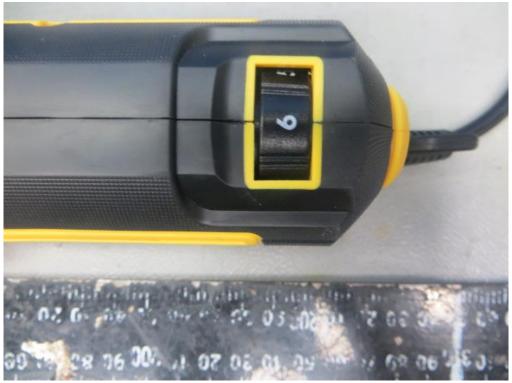


Photo 7 (Speed control knob)



Photo 8 (Collet)



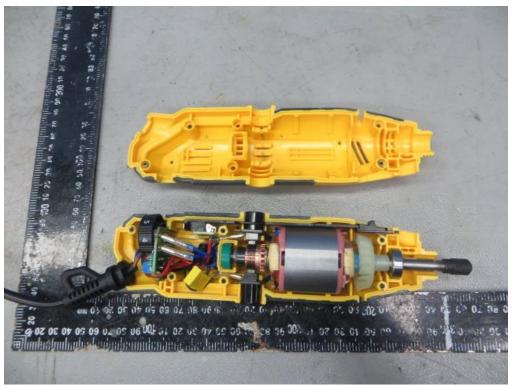


Photo 9 (inner view)

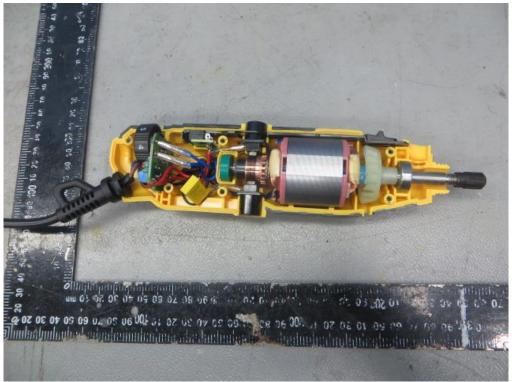


Photo 10 (inner view)



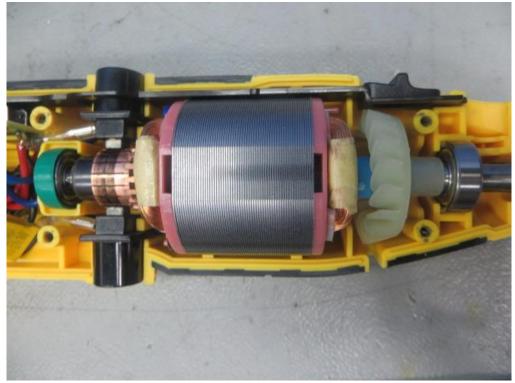


Photo 11 (Inner view)

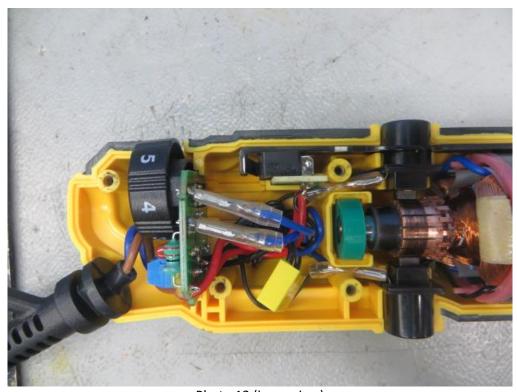


Photo 12 (inner view)





Photo 13 (PCB)

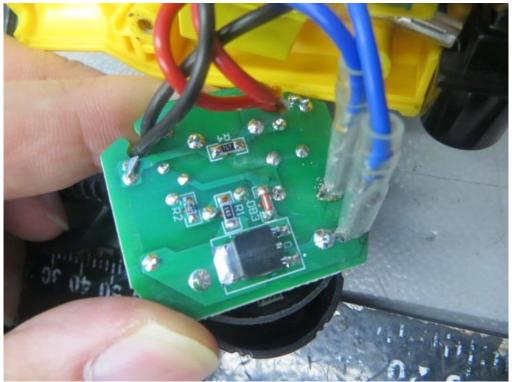


Photo 14 (Another view of PCB)





Photo 15 (Enclosure)



Photo 16 (Rotor)





Photo 17 (Stator)

\*\*\*END of the report\*\*\*